

Product data sheet

1. **Product profile**

1.1 General description

Passivated, sensitive gate triacs in a SOT54 plastic package

1.2 Features and benefits

Designed to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

1.3 Applications

General purpose switching and phase control

1.4 Quick reference data

- V_{DRM} ≤ 600 V (BT131-600)
- $I_{T(RMS)} \le 1 A$
- $V_{DRM} \le 800 \text{ V (BT131-800)}$
- $I_{TSM} \le 12.5 A$

Pinning information 2.

Table 1. **Pinning**

Pin	Description	Simplified outline	Symbol
1	main terminal 2 (T2)		N.I.
2	gate (G)		T2—T1
3	main terminal 1 (T1)		T2 — T1 G sym051
		SOT54 (TO-92)	



3. Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
BT131-600	TO-92	plastic single-ended leaded (through hole) package; 3 leads	SOT54
BT131-800			

4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage				
	BT131-600		[1] -	600	V
	BT131-800		-	800	V
I _{T(RMS)}	RMS on-state current	all conduction angles; T _{lead} = 51.2 °C; see <u>Figure 1</u> , <u>4</u> and <u>5</u>	-	1	А
I _{TSM}	non-repetitive peak on-state current	half sine wave; $T_j = 25 ^{\circ}\text{C}$ prior to surge; see Figure 2 and 3			
		t = 20 ms	-	12.5	Α
		t = 16.7 ms	-	13.8	Α
l ² t	I ² t for fusing	t = 10 ms	-	1.28	A ² s
dI _T /dt	rate of rise of on-state current	$I_{TM} = 1.5 \text{ A}; I_G = 20 \text{ mA};$ $dI_G/dt = 200 \text{ mA/}\mu\text{s}$			
		T2+ G+	-	50	A/μs
		T2+ G-	-	50	A/μs
		T2- G-	-	50	A/μs
		T2- G+	-	10	A/μs
l _{GM}	peak gate current		-	2	Α
P_{GM}	peak gate power		-	5	W
P _{G(AV)}	average gate power	over any 20 ms period	-	0.1	W
T _{stg}	storage temperature		-40	+150	°C
Tj	junction temperature		-	125	°C

^[1] Although not recommended, off-state voltages up to 800 V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 3 $A/\mu s$.

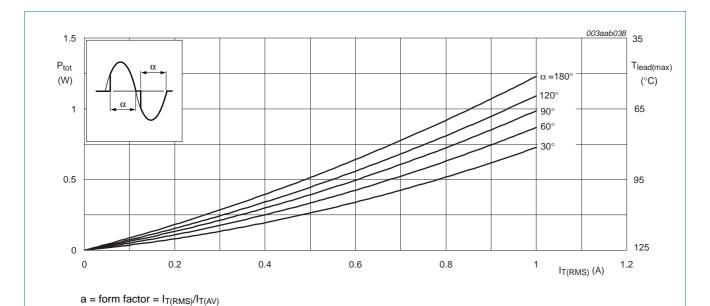
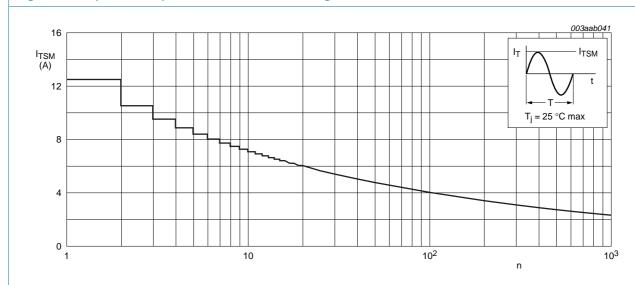
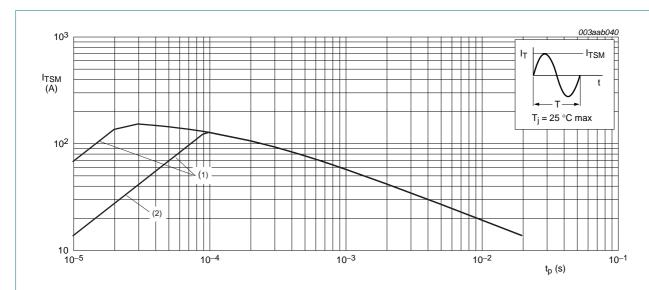


Fig 1. Total power dissipation as a function of average on-state current; maximum values



f = 50 Hz

Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



 $t_p \le 20 \text{ ms}$

- (1) dI_T/dt limit
- (2) T2- G+ quadrant

Fig 3. Non-repetitive peak on-state current as a function of pulse width for sinusoidal currents; maximum values

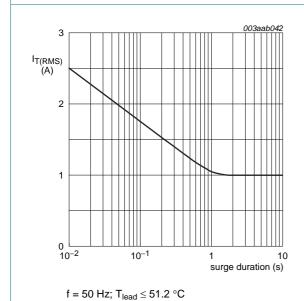
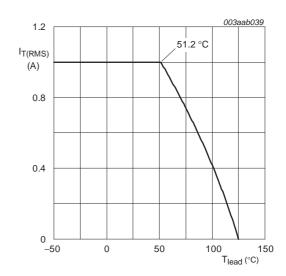


Fig 4. RMS on-state current as a function of surge duration, for sinusoidal currents; maximum values



(1) $T_{lead} = 51.2 \,^{\circ}C$

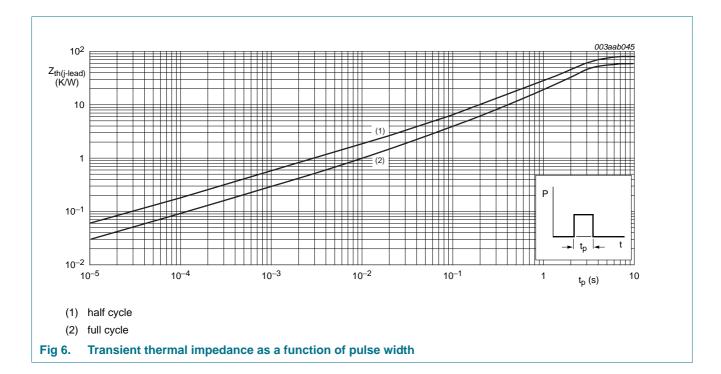
Fig 5. RMS on-state current as a function of lead temperature; maximum values

5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-lead)}$	thermal resistance from junction to	full cycle	-	-	60	K/W
	lead	half cycle	-	-	80	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	see Figure 6	[1] _	150	-	K/W

[1] Mounted on a printed-circuit board; lead length = 4 mm

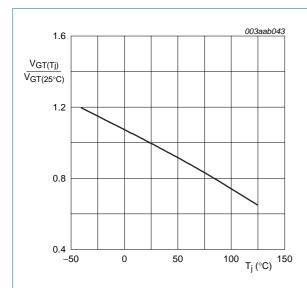


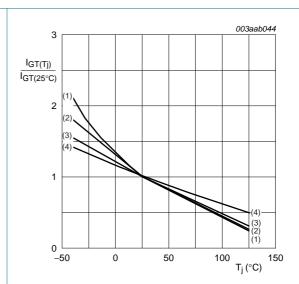
6. Characteristics

Table 5. Characteristics

 $T_i = 25 \,^{\circ}\text{C}$ unless otherwise stated.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	acteristics					
I _{GT}	gate trigger current	$V_D = 12 \text{ V; } I_T = 100 \text{ mA;}$ see Figure 8				
		T2+ G+	-	0.4	3	mA
		T2+ G-	-	1.3	3	mA
		T2- G-	-	1.4	3	mA
		T2- G+	-	3.8	7	mA
I _L	latching current	$V_D = 12 \text{ V; } I_{GT} = 100 \text{ mA;}$ see Figure 10				
		T2+ G+	-	1.2	5	mA
		T2+ G-	-	4	8	mA
		T2- G-	-	1	5	mA
		T2- G+	-	2.5	8	mA
l _H	holding current	$V_D = 12 \text{ V; } I_{GT} = 100 \text{ mA;}$ see Figure 11	-	1.3	5	mA
V_{T}	on-state voltage	I _T = 1.4 A; see <u>Figure 9</u>	-	1.2	1.5	V
V_{GT}	gate trigger voltage	I _T = 10 mA; gate open circuit; see Figure 7				
		$V_D = 12 \text{ V}; I_{GT} = 100 \text{ mA}$	-	0.7	1.5	V
		$V_D = 400 \text{ V}; I_{GT} = 100 \text{ mA};$ $T_j = 125 \text{ °C}$	0.2	0.3	-	V
I _D	off-state current	$V_D = V_{DRM(max)}$; $T_j = 125 ^{\circ}C$	-	0.1	0.5	mA
Dynamic c	haracteristics					
dV _D /dt	rate of rise of off-state voltage	$V_{DM} = 67 \% V_{DRM(max)}; T_j = 125 °C;$ exponential waveform; $R_{GK} = 1 k\Omega;$ see Figure 12	10	20	-	V/μs
dV _{com} /dt	rate of change of commutating current	$V_{DM} = 400 \text{ V}; T_j = 125 \text{ °C};$ $dI_{com}/dt = 0.5 \text{ A/ms}$	2	-	-	V/μs
t _{gt}	gate-controlled turn-on time	$I_{TM} = 1.5 \text{ A}; V_D = V_{DRM(max)};$ $I_G = 100 \text{ mA}; dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μS

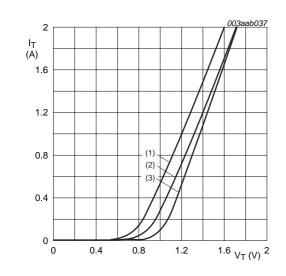




- (1) T2-G+
- (2) T2- G-
- (3) T2+ G-
- (4) T2+ G+

Fig 7. Normalized gate trigger voltage as a function of junction temperature





 $V_0 = 0.92 \text{ V}$

 $R_s = 0.4 \Omega$.

- (1) $T_j = 125$ °C; typical values
- (2) $T_i = 125 \,^{\circ}C$; maximum values
- (3) $T_i = 25 \,^{\circ}C$; maximum values

Fig 9. On-state current characteristics

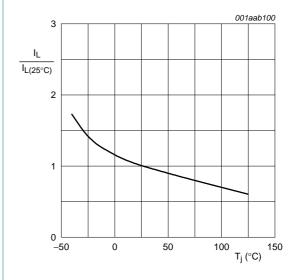


Fig 10. Normalized latching current as a function of junction temperature

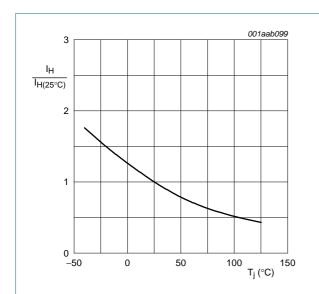


Fig 11. Normalized holding current as a function of junction temperature

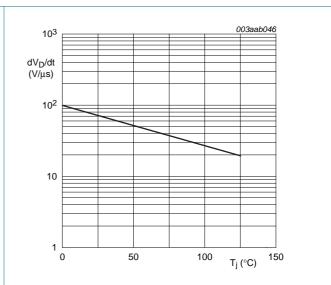


Fig 12. Rate of rise of off-state voltage as a function of junction temperature; minimum values

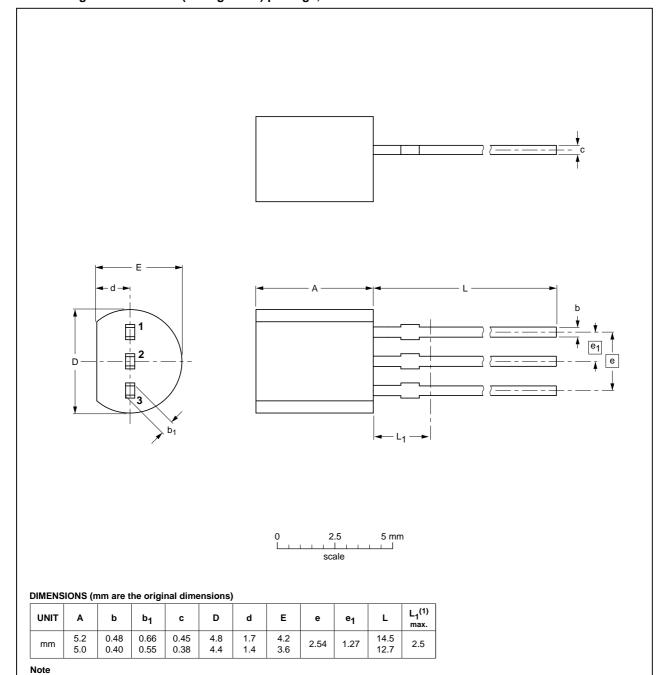
7. Package information

Epoxy meets requirements of UL94 V-0 at ½ inch.

Package outline

Plastic single-ended leaded (through hole) package; 3 leads

SOT54



1. Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

OUTLINE		REFER	ENCES		EUROPEAN PROJECTION IS	ISSUE DATE
VERSION	IEC	JEDEC	JEITA			ISSUE DATE
SOT54		TO-92	SC-43A			04-06-28 04-11-16

Fig 13. Package outline SOT54 (TO-92)

9. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BT131_SER v.9	20111109	Product data sheet	-	BT131_SER v.8
Modifications:		f this data sheet has been rede NXP Semiconductors.	esigned to comply w	ith the new identity
	 Legal texts h 	ave been adapted to the new	company name whe	re appropriate.
BT131_SER v.8	20050909	Product data sheet	-	BT131_SERIES v.7
BT131_SERIES v.7	20040101	Product specification	-	BT131_SERIES v.6
BT131_SERIES v.6	20030801	Product specification	-	BT131_SERIES v.5
BT131_SERIES v.5	20001201	Product specification	-	BT131_SERIES v.4
BT131_SERIES v.4	20000501	Product specification	-	BT131_SERIES v.3
BT131_SERIES v.3	19980401	Product specification	-	-

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10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design
- [2] The term 'short data sheet' is explained in section "Definitions"
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NXP Semiconductors

BT131 series

Triacs logic level

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BT131 series

Triacs logic level

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